JUN 2 9 2004 Doccet No.: GR 00 P 1679

2829 #

preby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the date indicated below.

By: Uff B

Date: June 23, 2004

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applic. No.

09/826,594

Confirmation No: 4825

Applicant

Dieter Kantz et al.

Filed

April 5, 2001

Title

Test Configuration for the Functional Testing of a

Semiconductor Chip

Art Unit

2829

Examiner

Ernest F. Karlsen

Docket No.

GR 00 P 1679

Customer No.:

24131

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. 1.97(d)

Hon. Commissioner for Patents

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

Japanese Utility Model JP 58-182444, dated December 5, 1983, and English description thereof;

Japanese Utility Model JP 2-110339, dated September 4, 1990, and English description thereof;

Patent Abstracts of Japan JP 4 199 726 (Hayashi), dated July 20, 1992;

Japanese Patent Application JP 5-264672 (Heumann et al.), dated October 12, 1993, and corresponding European Patent Application EP 0 551 564 A2, dated July 21, 1993;

Japanese Patent Application JP 6-84393 (Adams et al.), dated March 25, 1994, and corresponding European Patent Application EP 0561 131 A2, dated September 22, 1993;

Patent Abstracts of Japan JP 11 068 209 (Matsuzaka et al.), dated March 9, 1999;

Patent Abstracts of Japan JP 2000 048 131 (Takagi et al.), dated February 18, 2000;

Patent Abstracts of Japan JP 2000 188 311 (Murai et al.), dated July 4, 2000;

German translation of Japanese Office Action dated April 23, 2004.

In accordance with 37 C.F.R. 1.97(e) the undersigned herewith states that each item of information contained in the information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement.

In accordance with 37 C.F.R. 1.97 (d), consideration of this Information Disclosure Statement is requested.

Enclosed is the fee in the amount of \$180.00.

Respectfully submitted

For Applicants

Alfred K. Dassler 52,794

Date: June 23, 2004

Lerner And Greenberg, P.A. Post Office Box 2480 Hollywood, FL 33022-2480

Tel: (954) 925-1100 Fax: (954) 925-1101

/bmb

JUN 2	FORM TO-1449 (SUBSTITUTE) DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE				Attorney Docket No.: Applic. No. GR 00 P 1679 09/826,594 Applicant Dieter Kantz et al.				
		TEMEN	NT BY APPLICANT CFR 1.98(b))		Filing Date April 5, 2001	Group Art Unit 2829			
			U.S.	PATENT (DOCUMENTS				
	EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILI DA	
4	111111120	Α							-
	15	В							-
₩		С		1					-
		D							
		E							
- ,	***	F							
		G							
>		Н							
		1							
			FOREIG	GN PATE	NT DOCUMENT				
			DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRAI YES	
		J	58-182444	12/05/83	Japan	02,100	027.00	120	1.10
		К	2-110339	09/04/90	Japan				
		L	4 199 726	07/20/92	Japan				
		М	5-264672	10/12/93	Japan				-
		N	0 551 564 A2	07/21/93	Europe				
	ОТН	ER D	OCUMENTS (Incli	uding Auth	or, Title, Date, P	ertinent Pa	iges, etc.)	
		0							

EXAMINER DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

2 9°	FORM PTO-1449 (SUBSTITUTE) S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Attorney Docket No.: Applic. No. GR 00 P 1679 09/826,594 Applicant Dieter Kantz et al.			
BADE								
	514		OFR 1.98(b))		Filing Date April 5, 2001	Group Art Unit 2829		
			U.S.	PATENT I	DOCUMENTS			
	EXAMINER	T	DATENT NO	DATE	DATENITEE	CLASS	SUB CLASS	FILING DATE
İ	INITIALS	A	PATENT NO.	DATE	PATENTEE	CLASS	CLASS	DATE
		В						
		С						
	<u> </u>	D						
		E						
		F						
		G		· · · · · · · · · · · · · · · · · · ·				
		Н	-					
		1						
	L	<u></u>	FOREIG	SN PATE	NT DOCUMENT	<u> </u>	I	
			DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES I NO
١		J	6-84393	03/25/94	Japan	DEAGG	CLAGO	120 110
		К	0 561 131 A2	09/22/93	Europe			
		L	11 068 209	03/09/99	Japan	<u> </u>		
		М	2000 048 131	02/18/00	Japan			
		N	2000 188 311	07/04/00	Japan	<u> </u>		

P DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.